



Characterization of low energy ionization signals from Compton scattering in a CCD Dark Matter detector

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Motivation

- Solid state ionization detectors are integral component of next-generation dark matter searches due to their very low noise and the small band gap of semiconductor targets.
- However in this low energy search regime (2-1000e-) dominant background from environmental radiation are lowenergy electron recoils due to small-angle Compton Scattering of external gammas.
- Flux is orders of magnitude higher than fast neutrons the usual consideration for external source of signals
- Irreducible Electron Recoil background → any potential Dark Matter can only be identified by energy spectrum.
- \rightarrow Need complete understanding of low-energy spectral features.
- \rightarrow Expose UChicago Silicon CCD detector to gamma source

Motivation II

Expose to γ-ray source

Compton features + ?



Modeling

- Generically scattering cross-section given by textbook
 Klein-Nishina. However dealing with bound electrons.
 - Expect effectively flat spectrum (with these added steps)
- Impulse Approximation: Each atomic shell treated independently. Bound electrons are modeled as free with constrained momentum distribution derived from boundstate wave function.
 - Ribberfors 1982 (<u>https://doi.org/10.1103/PhysRevA.26.3325</u>)
 - Valid in our region of interest with low energy and momentum transfers
- Useful since we can obtain differential cross section expressions per atomic electron with quantum numbers n, l

Expected Spectrum



Silicon Target

- Visible Step features
 - Binding Energies

Provide linear parameterization (since in aggregate an unknown spectrum can be fit with straight lines...)

II. Experiment

Testbed (UChicago)



II. Experiment

Detection Principle



1x1 Data & MCNP Simulation Model



Fano Factor (@ 130 K)



Results - Cobalt



Results - Americium



L-Step

- Fano model should be valid
 - External modeling of all low-energy electrons emitted in Auger cascade (RELAX atomic relaxation spectra code)
- ▶ Calibration with Oxygen fluorescence x-rays \rightarrow 21 eV resolution at $E_g = 525 \text{ eV}$
- Interpret decreased resolution as coming from softened L step in electron spectrum
 - → Assumption that each atomic shell can be treated as independent does not hold? Many-body effects?

Model

- From 0.5-4 keV
- Initial 3 parameter model with fixed step heights discarded
- 6 parameter model
 - \rightarrow 2 slopes
 - $\rightarrow K$ step height
 - → L step location and resolution (σ_L)
 - \rightarrow Normalization

$$f(E) = A \times \begin{cases} a_1(E - E_K) + 1 & E \ge E_K \equiv E_{10} \\ a_2(E - E_K) + b_2 & E_L \le E < E_K \\ b_3 & E < E_L, \end{cases}$$

$$b_3 = \frac{Z - 10}{Z - 2} [b_2 + a_2(E_L - E_K)],$$

Model II

- 6 parameter model
 - \rightarrow 2 slopes
 - $\rightarrow K$ step height
 - → L step location and resolution
 - \rightarrow Normalization
- Able to model fit in <4 keV range to within 5% without accurate background knowledge
- Flattens out at high
 γ energies



Takeaway

<u>Primary</u>

- Report, for first time, spectral Compton features associated with the atomic structure of the target.
- Characterize the spectrum of low-energy ionization signals from electrons Compton scattered by radiogenic γ-rays, vital for future DM searches
- Validate applicability of simple linear model

<u>Secondary</u>

- Demonstrate again CCD resolution down to ~60 eV
- Measure Fano Factor @ operating temperature

Remains an open question as to what happens at low energies?





Questions?



Exclusion Plot



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Impulse Approximation

Expression valid only for $E > E_{nl}$, the target electron's binding energy. Otherwise it's 0 as the min. energy photon can lose is that required to free the target electron

 $J_{nl}(p_z)$ are the Compton profile functions, which encode the momentum distribution of the target electron and is taken from tabulated data. Further the integral can only be evaluated numerically.

Source Selection



Binning

- Hardware adding of neighboring pixels at serial register
 - e.g. 1×100 → 100 rows (y) transferred into serial register before clocking in x (column) direction
 - Fewer pixels but same noise per pixel



Dataset

Cobalt dataset taken early 2016, Americium early 2017

V. Backup

- Single 4k x 2k CCD (2.2 g mass)
- Analysis conducted using 4x4 data (1x1 used for validation)

Binning	Source	N images	V_{sub}	Event density
			[V]	$[\mathrm{keV}^{-1}]$
1×1	57 Co	1981	45	3.5×10^{4}
	Background	1235	45	4.3×10^{3}
	241 Am	971	45	4.7×10^{4}
	Background	2062	45	2.4×10^{3}
4×4	57 Co	1981	127	2.5×10^{5}
	Background	10276	127	2.6×10^{2}
	241 Am	9828	127	2.5×10^{5}
	Background	2062	127	1.1×10^{3}

Image Processing

- ▶ Pedestal (DC offset) subtraction → Pixel values centered at 0 with noise $\sigma_{\rm pix}$
- Mask "hot" pixels & lattice defects (~10% removed)
- Energy calibration done with fluorescence & P.E peaks
 - Linearity previously demonstrated using this setup
- IxI datasets
 - Clustering done by IIxII moving window maximizing difference in log-likelihood between 2 hypotheses: 2D Gaussian+Noise or just Noise.
- 4x4 datasets
 - Clusters identified as ionization events with contiguous pixels > 4 $\sigma_{\rm pix}$

1x1 Diffusion Modeling



Verifies that recorded spatial distribution is consistent with the signal from Compton scattering, with negligible contamination from surface events.

Efficiency



Pixel Cuts



 Energy threshold chosen to exclude readout noise.

 Negligible single pixel readout noise
 60 eV, but present for 2+ pixels until 80 eV.

Consider only single pixel events between 60-80 eV

"Sensei"

 Repeat measurement in near future

 Non destructive "skipper" readout R&D project.

 Perform N uncorrelated measurements for ~I/Sqrt(N) noise reduction

